

Search Notes

Application/Control No.

10/680,006

Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

KAPLAN, FREDERICK

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------------------------------------|-----------|------|
| 382/106, 107, 154 limited to text search | 2/10/2007 | AL |
| 382/103 limited to text search | 2/13/2007 | AL |
| 707 limited to text search | 2/14/2007 | AL |
| 382/171 limited to text search | 2/14/2007 | AL |
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